

P-Channel 2.5-V (G-S) MOSFET

PRODUCT SUMMARY		
V_{DS} (V)	$R_{DS(on)}$ (Ω)	I_D (A)
- 20	0.065 at $V_{GS} = - 4.5$ V	± 4.9
	0.074 at $V_{GS} = - 3.6$ V	± 4.6
	0.110 at $V_{GS} = - 2.5$ V	± 3.8

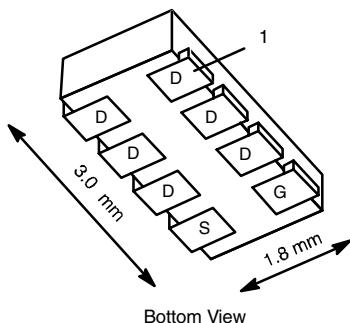
FEATURES

- Halogen-free According to IEC 61249-2-21 Available
- TrenchFET® Power MOSFETs: 2.5 V Rated



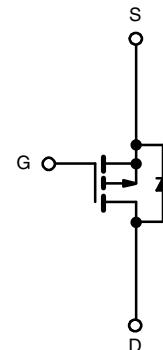
RoHS
COMPLIANT
HALOGEN
FREE
Available

1206-8 ChipFET®



Marking Code

 Lot Traceability and Date Code
 Part # Code



Ordering Information: Si5443DC-T1-E3 (Lead-(Pb)-free)
 Si5443DC-T1-GE3 (Lead-(Pb)-free and Halogen-free)

P-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS $T_A = 25$ °C, unless otherwise noted

Parameter	Symbol	5 s	Steady State	Unit
Drain-Source Voltage	V_{DS}	- 20		V
Gate-Source Voltage	V_{GS}		± 12	
Continuous Drain Current ($T_J = 150$ °C) ^a	I_D	± 4.9	± 3.6	A
		± 3.5	± 2.6	
Pulsed Drain Current	I_{DM}	± 15		A
Continuous Source Current ^a	I_{AS}	- 2.1	- 1.1	
Maximum Power Dissipation ^a	P_D	2.5	1.3	W
		1.3	0.7	
Operating Junction and Storage Temperature Range	T_J, T_{stg}	- 55 to 150		°C
Soldering Recommendations (Peak Temperature) ^{b, c}		260		

THERMAL RESISTANCE RATINGS

Parameter	Symbol	Typical	Maximum	Unit
Maximum Junction-to-Ambient ^a	$t \leq 5$ s	40	50	°C/W
	Steady State	80	95	
Maximum Junction-to-Foot (Drain)	R_{thJF}	15	20	

Notes:

- Surface Mounted on 1" x 1" FR4 board.
- See Reliability Manual for profile. The ChipFET is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- Rework Conditions: manual soldering with a soldering iron is not recommended for leadless components.

SPECIFICATIONS $T_J = 25^\circ\text{C}$, unless otherwise noted

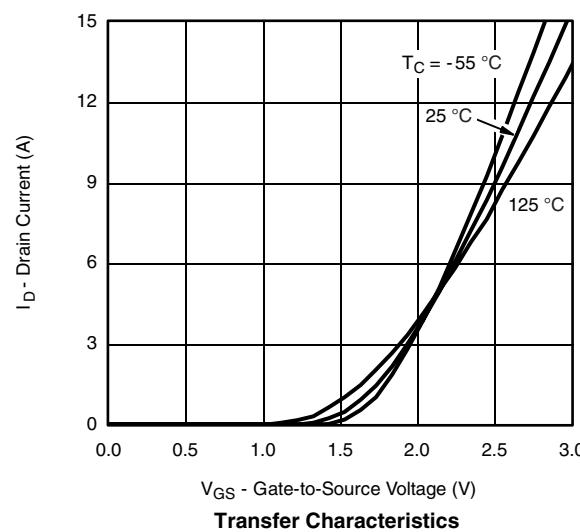
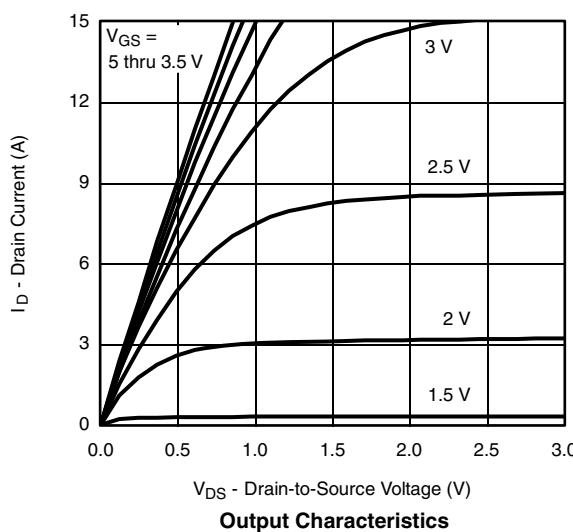
Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
Static						
Gate Threshold Voltage	$V_{GS(\text{th})}$	$V_{DS} = V_{GS}$, $I_D = -250 \mu\text{A}$	- 0.6			V
Gate-Body Leakage	I_{GSS}	$V_{DS} = 0 \text{ V}$, $V_{GS} = \pm 12 \text{ V}$			± 100	nA
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = -16 \text{ V}$, $V_{GS} = 0 \text{ V}$		- 1		μA
		$V_{DS} = -16 \text{ V}$, $V_{GS} = 0 \text{ V}$, $T_J = 85^\circ\text{C}$		- 5		
On-State Drain Current ^a	$I_{D(\text{on})}$	$V_{DS} \leq -5 \text{ V}$, $V_{GS} = -4.5 \text{ V}$	- 15			A
Drain-Source On-State Resistance ^a	$R_{DS(\text{on})}$	$V_{GS} = -4.5 \text{ V}$, $I_D = -3.6 \text{ A}$		0.056	0.065	Ω
		$V_{GS} = -3.6 \text{ V}$, $I_D = -3.3 \text{ A}$		0.065	0.074	
		$V_{GS} = -2.5 \text{ V}$, $I_D = -2.7 \text{ A}$		0.095	0.110	
Forward Transconductance ^a	g_{fs}	$V_{DS} = -10 \text{ V}$, $I_D = -3.6 \text{ A}$		10		S
Diode Forward Voltage ^a	V_{SD}	$I_S = -1.1 \text{ A}$, $V_{GS} = 0 \text{ V}$		- 0.8	- 1.2	V
Dynamic^b						
Total Gate Charge	Q_g	$V_{DS} = -10 \text{ V}$, $V_{GS} = -4.5 \text{ V}$, $I_D = -3.6 \text{ A}$		9	14	nC
Gate-Source Charge	Q_{gs}			2.2		
Gate-Drain Charge	Q_{gd}			2.2		
Turn-On Delay Time	$t_{d(\text{on})}$	$V_{DD} = -10 \text{ V}$, $R_L = 10 \Omega$ $I_D \geq -1 \text{ A}$, $V_{GEN} = -4.5 \text{ V}$, $R_G = 6 \Omega$		15	25	μs
Rise Time	t_r			30	45	
Turn-Off Delay Time	$t_{d(\text{off})}$			50	75	
Fall Time	t_f			35	50	
Source-Drain Reverse Recovery Time	t_{rr}	$I_F = -1.1 \text{ A}$, $dl/dt = 100 \text{ A}/\mu\text{s}$		30	60	ns

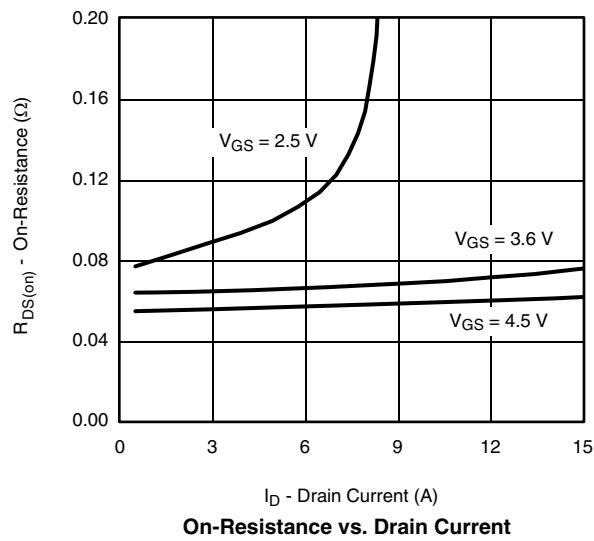
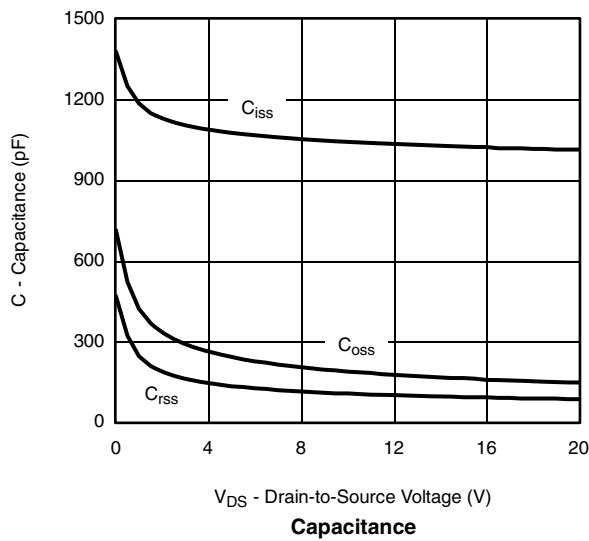
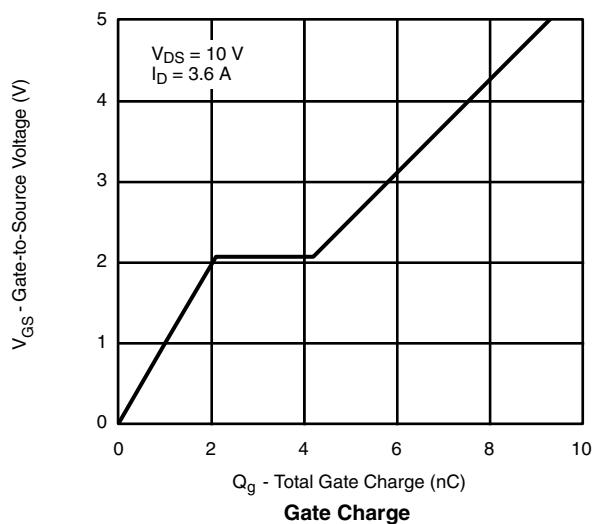
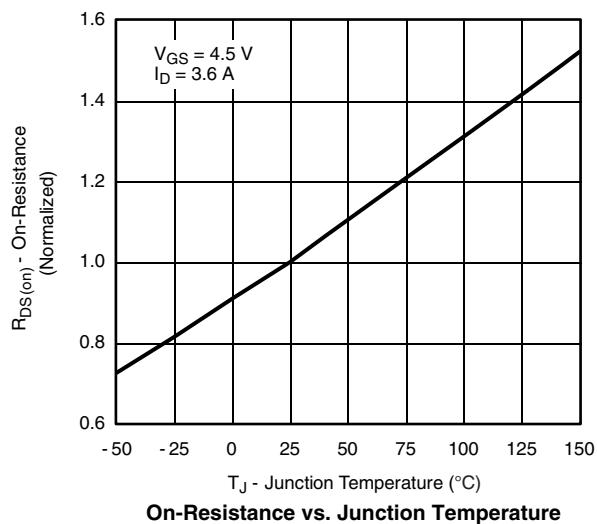
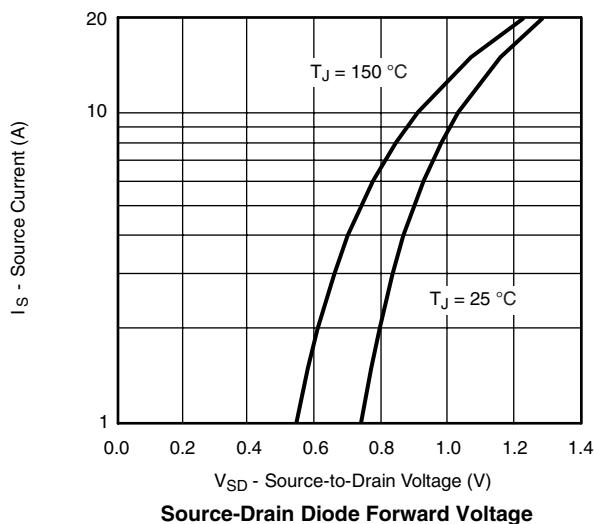
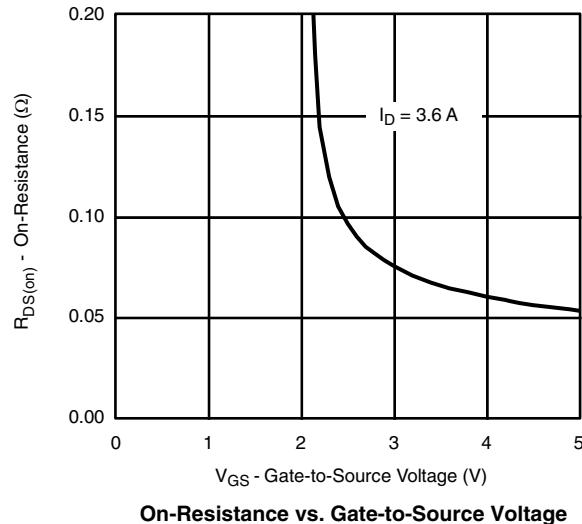
Notes:

a. Pulse test; pulse width $\leq 300 \mu\text{s}$, duty cycle $\leq 2 \%$.

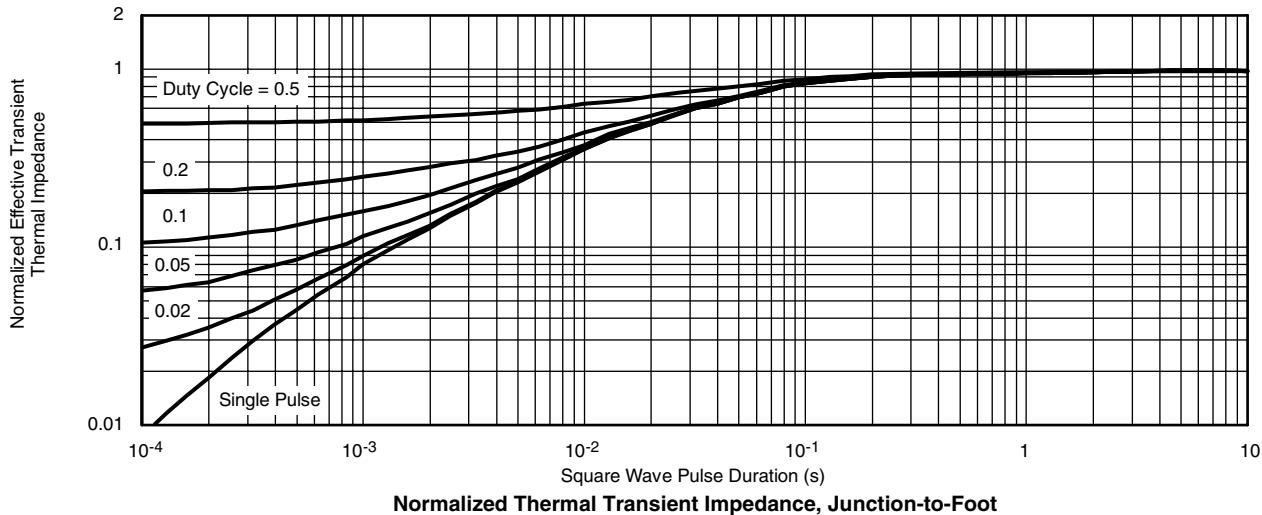
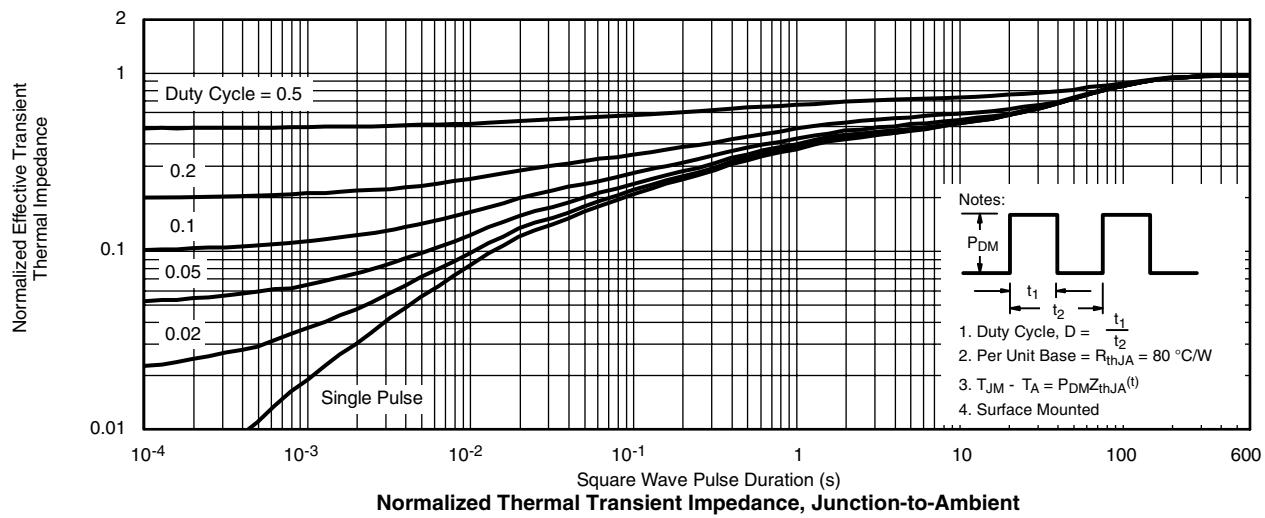
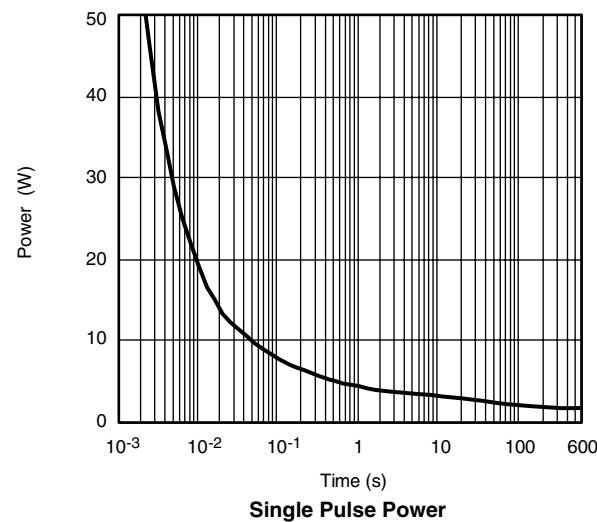
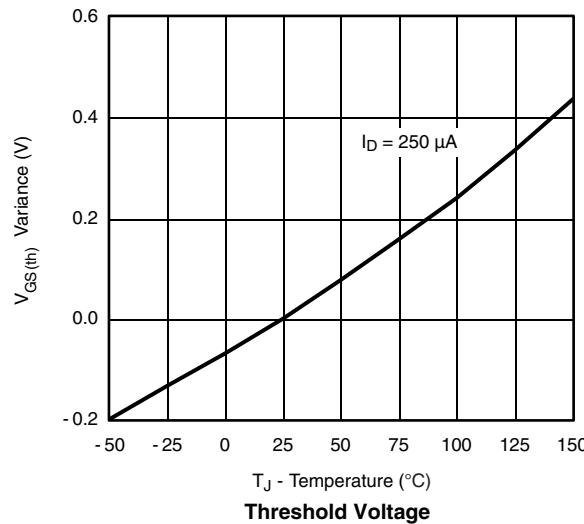
b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

TYPICAL CHARACTERISTICS 25°C , unless otherwise noted


TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

On-Resistance vs. Drain Current

Capacitance

Gate Charge

On-Resistance vs. Junction Temperature

Source-Drain Diode Forward Voltage

On-Resistance vs. Gate-to-Source Voltage

TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



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